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| Notice of References Cited | Application/Control No. 10/812,806 | Applicant(s)/Patent Under Reexamination KERKER ET AL. | |
| | Examiner Thien T. Mai | Art Unit 2876 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-2004/0172260 | 09-2004 | Junger et al. | 705/001 |
| | B | US-2004/0044586 | 03-2004 | Gullo et al. | 705/026 |
| * | C | US-2005/0114221 | 05-2005 | Walters et al. | 705/026 |
| * | D | US-2002/0032612 | 03-2002 | Williams et al. | 705/26 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
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